September 1998

National Semiconductor

100371 Low Power Triple 4-Input Multiplexer with Enable

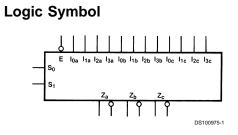
General Description

The 100371 contains three 4-input multiplexers which share a common decoder (inputs S_0 and S_1). Output buffer gates provide true and complement outputs. A HIGH on the Enable input (\overline{E}) forces all true outputs LOW (see Truth Table). All inputs have 50 k Ω pull-down resistors.

- 2000V ESD protection
- Pin/function compatible with 100171
- Voltage compensated operating range = -4.2V to -5.7V
- Available to MIL-STD-883

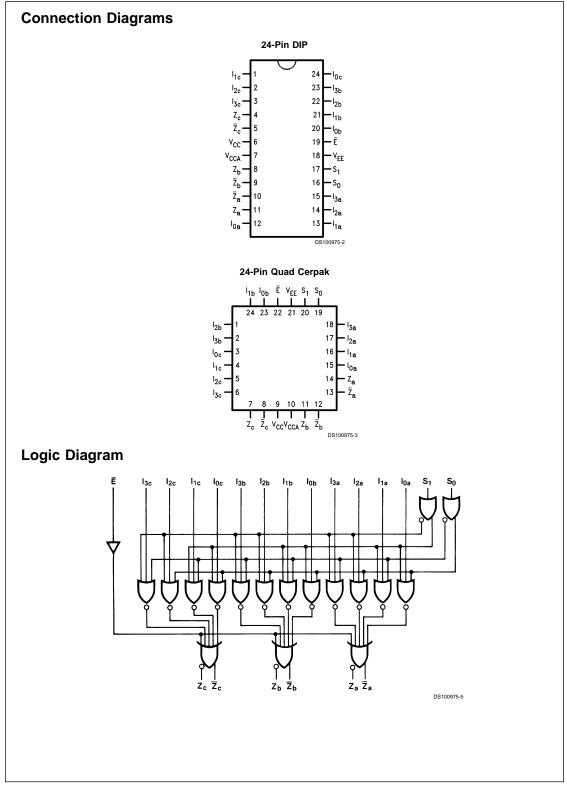
Features

■ 35% power reduction of the 100171



Pin Names	Description
I _{0x} -I _{3x}	Data Inputs
S ₀ , S ₁	Select Inputs
Ē	Enable Input (Active LOW)
Z _a -Z _c	Data Outputs
\overline{Z}_{a} - \overline{Z}_{c}	Complementary Data Outputs

© 1998 National Semiconductor Corporation DS100975



Truth Table

	Inputs					
Ē	So	S ₁	Zn			
L	L	L	I _{0x}			
L	н	L	I _{1x}			
L	L	н	l _{2x}			
L	н	н	l _{3x}			
н	Х	Х	L			

H = HIGH Voltage Level L = LOW Voltage Level X = Don't Care

Absolute Maximum Ratings (Note 1)

.

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Storage Temperature (T _{STG})	–65°C to +150°C
Maximum Junction Temperature (T _J)	
Ceramic	+175°C
V _{EE} Pin Potential to Ground Pin	-7.0V to +0.5V
Input Voltage (DC)	V _{EE} to +0.5V
Output current (DC Output HIGH)	–50 mA
ESD (Note 2)	≥2000V

Military Version DC Electrical Characteristics

Conditions Case Temperature (T_c)

Recommended Operating

 Military
 -55°C to +125°C

 Supply Voltage (V_{EE})
 -5.7V to -4.2V

 Note 1: Absolute maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

 Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Symbol	Parameter	Min	Max	Units	Tc	Condit	tions	Notes
V _{OH}	Output HIGH Voltage	-1025	-870	mV	0°C to			
					+125°C			
		-1085	-870	mV	–55°C	V _{IN} = V (Max)	Loading with	(Notes 3, 4,
V _{OL}	Output LOW Voltage	-1830	-1620	mV	0°C to	or V _{IL (Min)}	50Ω to $-2.0V$	5)
					+125°C			
		-1830	-1555	mV	–55°C			
V _{OHC}	Output HIGH Voltage	-1035		mV	0°C to			
					+125°C			
		-1085		mV	–55°C	$V_{IN} = V_{IH}$ (Min)	Loading with	(Notes 3, 4,
V _{OLC}	Output LOW Voltage		-1610	mV	0°C to	or V _{IL} (Max)	50Ω to -2.0V	5)
					+125°C			
			-1555	mV	–55°C			
V _{IH}	Input HIGH Voltage	-1165	-870	mV	–55°C to	Guaranteed HIGH	Signal	(Notes 3, 4,
					+125°C	for All Inputs		5, 6)
VIL	Input LOW Voltage	-1830	-1475	mV	–55°C to	Guaranteed LOW	Signal	(Notes 3, 4,
					+125°C	for All Inputs		5, 6)
I _{IL}	Input LOW Current	0.50		μA	–55°C to	$V_{EE} = -4.2V$		(Notes 3, 4,
					+125°C	$V_{IN} = V_{IL}$ (Min)		5)
I _{IH}	Input HIGH Current							
	I _{0X} -I _{3X}		340	μA	0°C to			()
	S_0, S_1, \overline{E}		300		+125°C	$V_{EE} = -5.7V$		(Notes 3, 4, 5)
	I _{0X} -I _{3X}		490	μA	–55°C	$V_{IN} = V_{IH}$ (Max)		3)
	S ₀ , S ₁ , Ē		450					
I_{EE}	Power Supply Current	-80	-30	mA	–55°C to	Inputs Open		(Notes 3, 4,
					+125°C			5)

Note 3: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals -55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissapation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 4: Screen tested 100% on each device at -55°C, +25°C, and +125°C, Subgroups 1, 2, 3, 7, and 8.

Note 5: Sample tested (Method 5005, Table I) on each manufactured lot at -55°C, +25°C, and +125°C, Subgroups 1, 2, 3, 7, and 8.

Note 6: Guaranteed by applying specified input condition and testing V_{OH}/V_{OL}.

Military Version AC Electrical Characteristics V _{EE} = -4.2V to -5.7V, V _{CC} = V _{CCA} = GND										
Symbol	Parameter	T _c =	–55°C	T _c =	+25°C	T _c = -	⊦125°C	Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max	1		
t _{PLH}	Propagation Delay	0.10	1.90	0.20	1.70	0.20	2.00	ns		
t _{PHL}	I _{0x} -I _{3x} to Output									
t _{PLH}	Propagation Delay	0.40	2.70	0.60	2.40	0.50	2.90	ns		(Notes 7,
t _{PHL}	S ₀ , S ₁ to Output								Figures 1, 2	8, 9, 11)
t _{PLH}	Propagation Delay	0.50	2.70	0.60	2.40	0.50	2.90	ns		
t _{PHL}	E to Output									
t _{TLH}	Transition Time	0.20	1.60	0.30	1.50	0.20	1.60	ns		(Nata 10)
t _{THL}	20% to 80%, 80% to 20%									(Note 10)

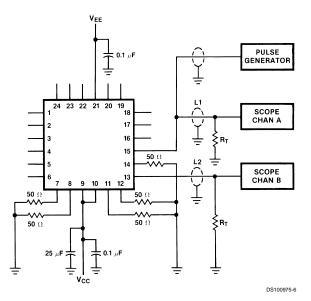
Note 7: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals -55°C), then testing immediately after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 8: Screen tested 100% on each device at +25°C temperature only, Subgroup A9.

Note 9: Sample tested (Method 5005, Table I) on each mfg. lot at +25°C, Subgroup A9, and at +125°C and -55°C temperatures, Subgroups A10 and A11. Note 10: Not tested at +25°C, +125°C and -55°C temperature (design characterization data).

Note 11: The propagation delay specified is for single output switching. Delays may vary up to 300 ps with multiple outputs switching.

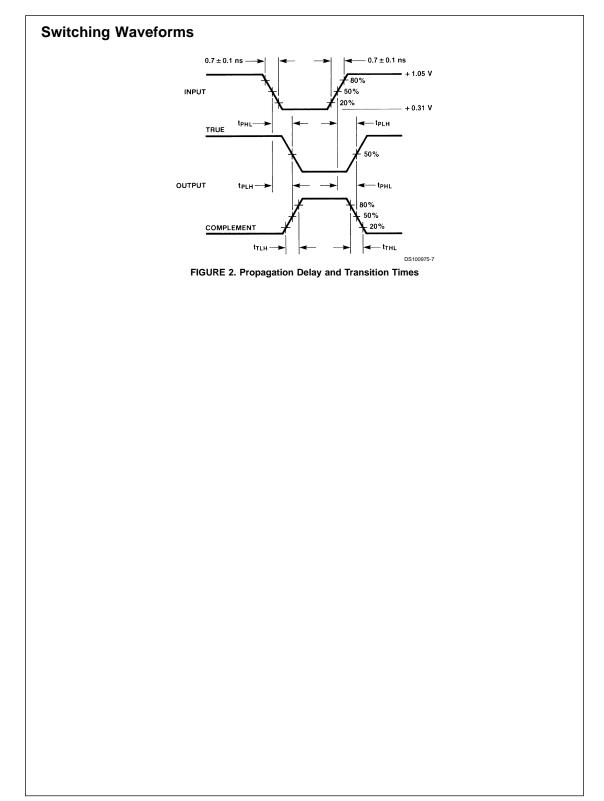
Test Circuitry

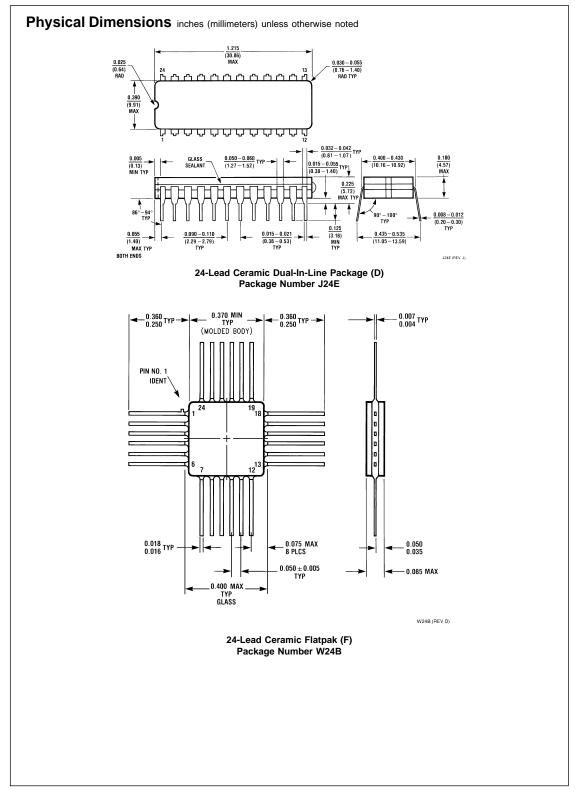


Notes:

 V_{CC} , V_{CCA} = +2V, V_{EE} = -2.5V L1 and L2 = equal length 50 Ω impedance lines $R_T = 50\Omega$ terminator internal to scope Decoupling 0.1 μF from GND to V_{CC} and V_{EE} All unused outputs are loaded with 50Ω to GND C_L = Fixture and stray capacitance \leq 3 pF Pin numbers shown are for flatpak; for DIP see logic symbol

FIGURE 1. AC Test Circuit





LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DE-VICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF NATIONAL SEMI-CONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

National Semiconductor	National Semiconductor	National Semiconductor	National Semiconducto
Corporation	Europe	Asia Pacific Customer	Japan Ltd.
Americas	Fax: +49 (0) 1 80-530 85 86	Response Group	Tel: 81-3-5620-6175
Tel: 1-800-272-9959	Email: europe.support@nsc.com	Tel: 65-2544466	Fax: 81-3-5620-6179
Fax: 1-800-737-7018	Deutsch Tel: +49 (0) 1 80-530 85 85	Fax: 65-2504466	
Email: support@nsc.com	English Tel: +49 (0) 1 80-532 78 32	Email: sea.support@nsc.com	
	Français Tel: +49 (0) 1 80-532 93 58		
ww.national.com	Italiano Tel: +49 (0) 1 80-534 16 80		

National does not assume any responsibility for use of any circuity described, no circuit patent licenses are implied and National reserves the right at any time without notice to change said circuitry and specifications.



 Package Availability, Models, Samples & Pricing

General Description

The 100371 contains three 4-input multiplexers which share a common decoder (inputs S_0 and S_1). Output buffer gates provide true and

complement outputs. A HIGH on the Enable input (E#) forces all true outputs LOW (see Truth Table). All inputs have 50 k Ohm pull-down resistors.

Features

- 35% power reduction of the 100171
- 2000V ESD protection
- Pin/function compatible with 100171
- Voltage compensated operating range = -4.2V to -5.7V
- Available to MIL-STD-883

Datasheet

Title	Size (in Kbytes)	Date	View Online	X Download	Receive via Email
100371 Low Power Triple 4-Input Multiplexer with Enable	1122	23- Sep- 98	<u>View</u> Online	Download	<u>Receive via</u> <u>Email</u>
100371 Mil-Aero Datasheet MN100371-X	106 Kbytes		<u>View</u> Online	<u>Download</u>	<u>Receive via</u> <u>Email</u>

Please use <u>Adobe Acrobat</u> to view PDF file(s). If you have trouble printing, see <u>Printing Problems</u>.

Package Availability, Models, Samples & Pricing

David	Packa	ige		Mod	els	Samples	Budgeta	ry Prio
Part Number	Туре	# pins	Status	SPICE	IBIS	& Electronic Orders	Quantity	\$US (
100371DMQB	Cerdip	24	Full production	N/A	N/A	× Order	50+	\$38.8
100371FMQB	Cerpack	24	Full production	N/A	N/A	X Order	50+	\$41.2
100371DM- MLS	Cerdip	24	Full production	N/A	N/A		50+	\$280.
100371FM- MLS	Cerpack	24	Full production	N/A	N/A		50+	\$280.
100371 MD8	die		Full production	N/A	N/A			
100371 MW8	wafe	er	Full production	N/A	N/A			

[Information as of 7-Mar-2001]

Quick Search	Parametric Search	<u>System</u> Diagrams	Product Tree	Home
--------------	----------------------	---------------------------	-----------------	------

<u>About Languages</u> . <u>Website Guide</u> . <u>About "Cookies"</u> . National is <u>QS 9000 Certified</u> <u>Site Terms & Conditions of Use</u> . Copyright 2001 © National Semiconductor Corporation <u>Privacy/Security Statement</u> . <u>Preferences</u> . <u>Feedback</u>